TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ( $\pi$ -MOSVI)

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# 2SK3797

### **Switching Regulator Applications**

• Low drain-source ON resistance: RDS (ON) =  $0.32 \Omega$  (typ.)

• High forward transfer admittance:  $|Y_{fs}| = 7.5 \text{ S (typ.)}$ 

• Low leakage current: IDSS = 100  $\,\mu$  A (VDS = 600 V)

• Enhancement model:  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

### Maximum Ratings (Ta = 25°C)

Characte	eristic	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	600	V	
Drain-gate voltage (R	$R_{GS} = 20 \text{ k}\Omega$	$V_{DGR}$	600	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
	DC (Note 1)	ΙD	13	А	
Drain current	Pulse (t = 1 ms) (Note 1)	I <sub>DP</sub>	52		
Drain power dissipati	on (Tc = 25°C)	P <sub>D</sub>	50	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	1033	mJ	
Avalanche current		I <sub>AR</sub>	13	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	5.0	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	

# Unit: mm \$\frac{1.14 \pm 0.15}{0.69 \pm 0.20} \text{A} \text{A} \text{B} \text{C} \text{2.54} \text{2.54} \text{2.54} \text{2.54} \text{2.54} \text{2.54} \text{2.54} \text{2.554} \text{

Weight: 1.7 g (typ.)

### **Thermal Characteristics**

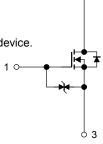
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	2.5	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C during use of the device.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 10.7 mH,  $I_{AR}$  = 13 A,  $R_G$  = 25  $\Omega$ 

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



**Ω** 

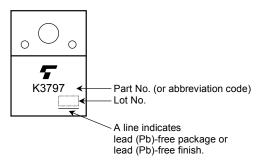
# **Electrical Characteristics (Ta = 25°C)**

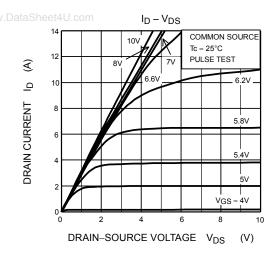
aSheet4U.cc <b>Cha</b> i	racteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cui	rent	I <sub>GSS</sub>	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Gate-source brea	akdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cutoff curre	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	_	100	μА
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	600	_	_	V
Gate threshold v	oltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source ON	resistance	R <sub>DS (ON)</sub>	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$	_	0.32	0.43	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.0 A	2.1	7.5	_	S
Input capacitance	e	C <sub>iss</sub>		_	3100	_	
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	20	_	pF
Output capacitance		C <sub>oss</sub>		_	270	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS}$ $V_{OV}$ $V$	_	60		
	Turn-on time	t <sub>on</sub>			110	_	ns
	Fall time	t <sub>f</sub>			50	_	
	Turn-off time	t <sub>off</sub>	Duty $\leq$ 1%, $t_W = 10 \ \mu s$	_	215	_	
Total gate charge	otal gate charge			_	62	_	_
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 13 \text{ A}$	_	40	_	nC
Gate-drain charge		Q <sub>gd</sub>		_	22	_	

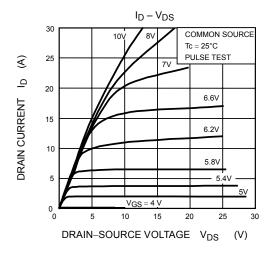
# Source-Drain Ratings and Characteristics (Ta = 25°C)

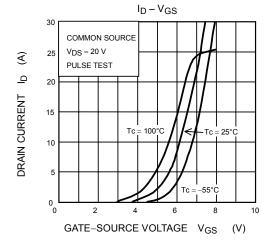
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current	(Note 1)	I <sub>DR</sub>	_		_	13	Α
Pulse drain reverse current	(Note 1)	I <sub>DRP</sub>	_	_	_	52	Α
Forward voltage (diode)		$V_{DSF}$	$I_{DR} = 13 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time		t <sub>rr</sub>	$I_{DR} = 13 \text{ A}, V_{GS} = 0 \text{ V},$	_	1050	_	ns
Reverse recovery charge		Q <sub>rr</sub>	dI <sub>DR</sub> /dt = 100 A/μs	_	15	_	μС

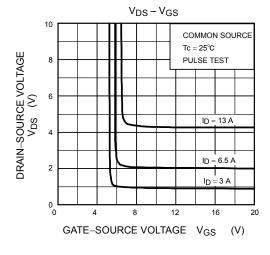
# Marking

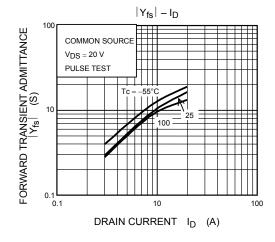


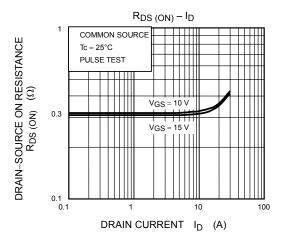


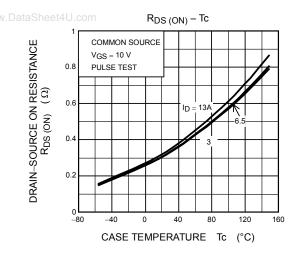


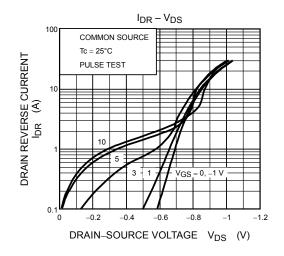


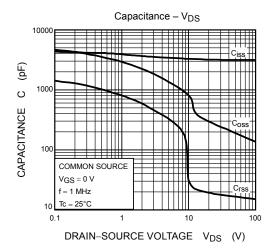


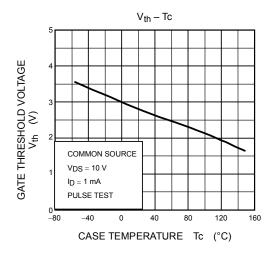


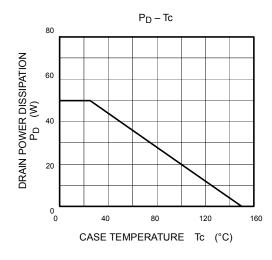


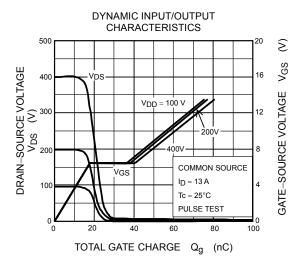




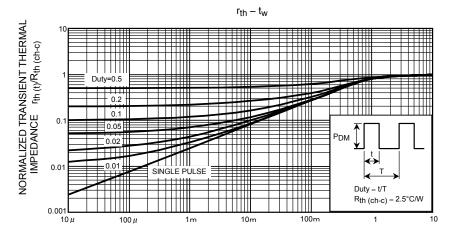




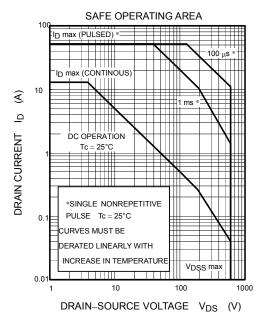


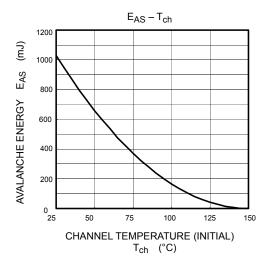


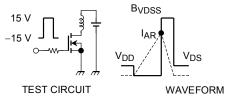
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PULSE WIDTH  $t_w$  (s)







$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 10.7 mH \end{aligned}$$

$$\mathsf{E}_{AS} = \frac{1}{2} \cdot L \cdot l^2 \cdot \left( \frac{\mathsf{BVDSS}}{\mathsf{BVDSS} - \mathsf{VDD}} \right)$$

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